



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2811
Examiner: To Be Assigned

INFORMATION DISCLOSURE

STATEMENT

In Re PATENT APPLICATION Of:

Applicant(s): Yoshimi EGAWA

Serial No.: 10/722,419

Filed: November 28, 2003

For: SEMICONDUCTOR DEVICE AND

MANUFACTURING METHOD

THEREOF

Atty Ref.: OKI 388

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(3), i.e., prior to a first Office Action on the merits.

Attached are copies of five Japanese patent publications, which were cited in the attached Japanese Office Action dated March 16, 2004. The Action was issued by the Japanese Patent Office in connection with a Japanese counterpart application. Also attached are English-language abstracts of the Japanese patent publications, and English-language translations of respective ones of the publications, from which any relevance of the documents may be gleaned. The publications are listed on the attached Form PTO-1449.

Since this Information Disclosure Statement is being filed before a first Office Action, no certification or fee is required, and the requirements of 37 C.F.R.



Atty Dkt: OKI 388

§§1.97 and 1.98 are deemed to be fully met as to all documents listed. Consideration of the listed documents respectfully is requested.

Should any fee be required, please charge the same to our Deposit Account No. 18-0002 and advise us accordingly.

October 19, 2004

Date

Respectfully submitted,

Robert H. Berdo, Jr. (Reg. No. 38, 075)

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RHB:vm



FORM PTO-1449				Atty. Docket	Applica	Application No.		
INFORMATION DISCLOSURE STATEMENT				OKI 388	1	10/722,419		
				Applicant Yoshimi EGAWA				
				Filing Date November 28, 2003	Group 28	Group 2811		
U.S. PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	. Name	Class	Sub- Class	Filing Date	
	AA							
	. AB							
	AC	•						
	AD							
	AE							
	AF						-	
	AG						····	
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FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Sub- Class	Trans- lation	
	AI	2002–124625	04/26/02	JAPAN			Abstract, Translation	
	AJ	63–52461	03/05/88	JAPAN			Abstract	
	AK	2001–94045	04/06/01	JAPAN			Abstract, Translation	
	AL	11–297927	10/29/99	JAPAN			Abstract, Translation	
<u> </u>	AM	2003–224228	08/08/03	JAPAN			Abstract, Translation	
	AN						Translation	
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)								
	AO							
Examiner Date Considered						ed		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.								